

UNISONIC TECHNOLOGIES CO., LTD

11N80-FC2 **Preliminary**

11A, 800V N-CHANNEL POWER MOSFET

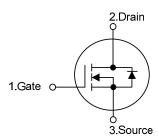
DESCRIPTION

The UTC 11N80-FC2 is a high voltage power MOSFET combines advanced trench MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

FEATURES

- * $R_{DS(ON)} \le 0.97 \Omega$ @ $V_{GS}=10V$, $I_{D}=5.5A$
- * Fast switching capability
- * Avalanche energy tested
- * Improved dv/dt capability, high ruggedness

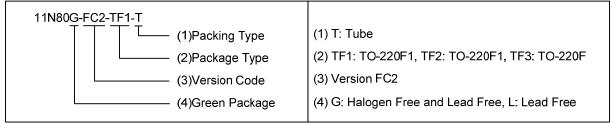




ORDERING INFORMATION

Ordering Number		Daaltana	Pin	Assignm	Daakina		
Lead Free	Halogen Free	Package	1	2	3	Packing	
11N80L-FC2-TF1-T	11N80G-FC2-TF1-T	TO-220F1	G	D	S	Tube	
11N80L-FC2-TF2-T	11N80G-FC2-TF2-T	TO-220F2	G	D	S	Tube	
11N80L-FC2-TF3-T	11N80G-FC2-TF3-T	TO-220F	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source

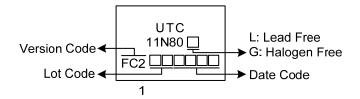


TO-220F TO-220F1 TO-220F2

Power MOSFET

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■ MARKING



■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	800	V
Gate-Source Voltage		V_{GSS}	±30	V
Continuous Drain Current		I_{D}	11	Α
Pulsed Drain Current (Note 2)		I_{DM}	22	Α
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	70	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	2.7	V/ns
Power Dissipation		P_D	40	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T_{STG}	-55 ~ +150	°C

- Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

 Absolute maximum ratings are stress ratings only and functional device operation is not implied.
 - 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
 - 3. L = 10mH, I_{AS} =3.75 A, V_{DD} = 90V, R_G = 25 Ω , Starting T_J = 25°C
 - 4. $I_{SD} \le 11A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	θ_{JA}	62.5	°C/W	
Junction to Case	θις	3.125	°C/W	

■ ELECTRICAL CHARACTERISTICS (T_J=25°C, unless otherwise specified)

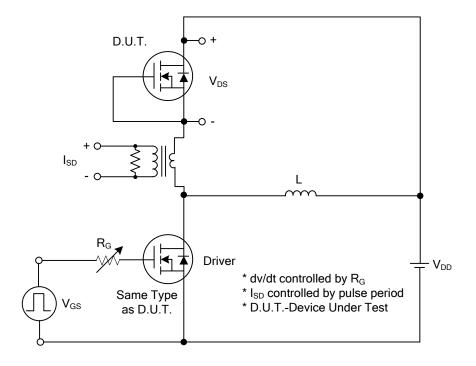
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} =0V, I _D =250μA	800			V	
Drain-Source Leakage Current		I _{DSS}	V _{DS} =800V, V _{GS} =0V			10	μΑ	
Gate- Source Leakage Current	Forward	1	V _{GS} =30V, V _{DS} =0V			100	nA	
	Reverse	lgss	V _{GS} =-30V, V _{DS} =0V			-100	nA	
ON CHARACTERISTICS								
Gate Threshold Voltage		V _{GS(TH)}	V _{DS} =V _{GS} , I _D =250µA	3.0		5.0	V	
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =5.5A			0.97	Ω	
DYNAMIC CHARACTERISTICS								
nput Capacitance		C _{ISS}			2080		pF	
Output Capacitance		Coss	V _{DS} =25V, V _{GS} =0V, f=1.0MHz		182		pF	
Reverse Transfer Capacitance		C _{RSS}			1.7		pF	
SWITCHING CHARACTERISTICS								
Total Gate Charge (Note 1)		Q_{G}	V _{DS} =640V, V _{GS} =10V, I _D =11A		41		nC	
Gate-Source Charge		Q _{GS}	(Note 1, 2)		17		nC	
Gate-Drain Charge		Q_{GD}	(Note 1, 2)		9		nC	
Turn-On Delay Time (Note 1)		t _{D(ON)}			41		ns	
Turn-On Rise Time		t _R	V _{DS} =100V, V _{GS} =10V, I _D =11A,		20		ns	
Turn-Off Delay Time		t _{D(OFF)}	R _G =25Ω (Note 1, 2)		67		ns	
Turn-Off Fall Time		t _F			30		ns	
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS								
Maximum Body-Diode Continuous Current		Is				11	Α	
Maximum Body-Diode Pulsed Current		I _{SM}				22	Α	
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I _S =11A , V _{GS} =0V			1.4	V	
Reverse Recovery Time (Note 1)		t _{rr}	I _S =11A , V _{GS} =0V		470		ns	
Reverse Recovery Charge		Qrr	di/dt=100A/µs		6.9		μC	

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

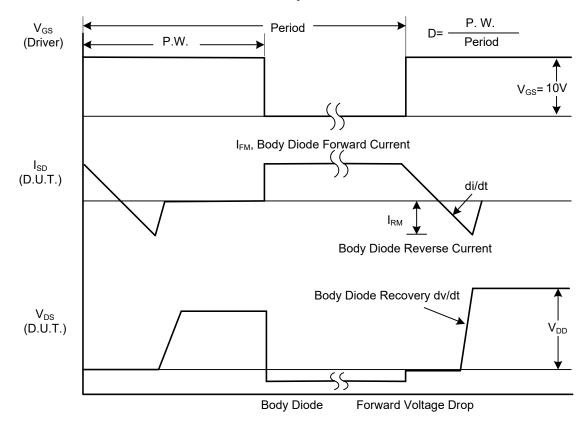
2. Essentially independent of operating temperature.



■ TEST CIRCUITS AND WAVEFORMS

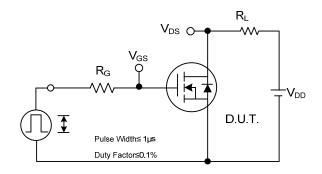


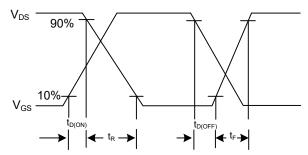
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

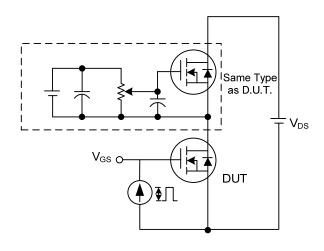
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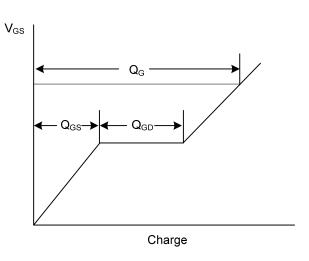




Switching Test Circuit

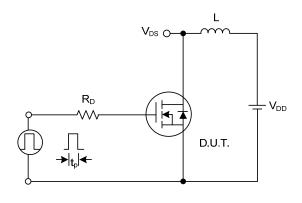
Switching Waveforms

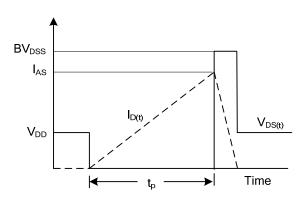




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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